

Programmable Overvoltage Protector

G170B

General Description

This device is especially designed to protect Subscriber Line Interface Circuit (SLIC) against transient overvoltage. Positive overloads are clipped with 2 diodes. Negative surges are suppressed by 2 thyristors, their breakdown voltage being referenced to V_{BAT} through the gate.

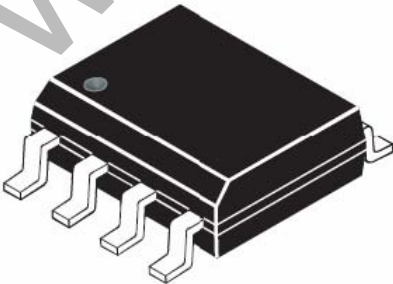
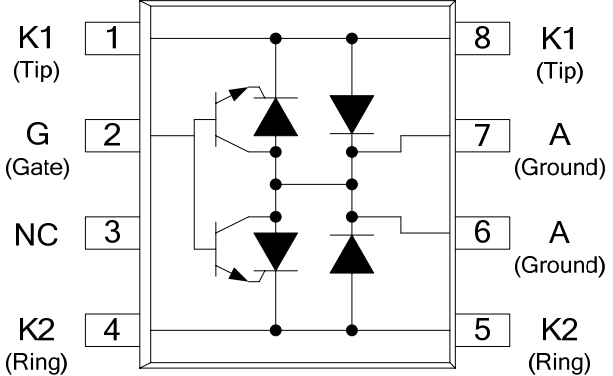
This component presents a very low gate triggering current and minimizes overvoltage stress on the SLIC.

Features

- Dual programmable transient suppressor
- Wide battery voltage supports
- Low gate triggering current
- High holding current
- ESD Immunity(HBM): JESD22 Class 3B, $\geq 8KV$
- MLS: Level 1-unlimited
- Marking: G170B

Applications

- Switch Line Card
- Access Network Line Card
- PBX
- VoIP

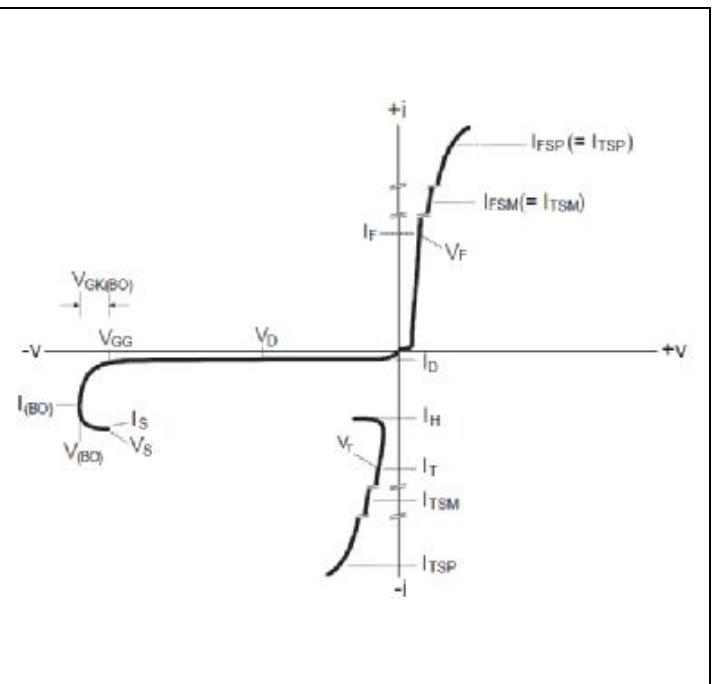
Package	Device Symbol
 <p>SOP-8</p>	

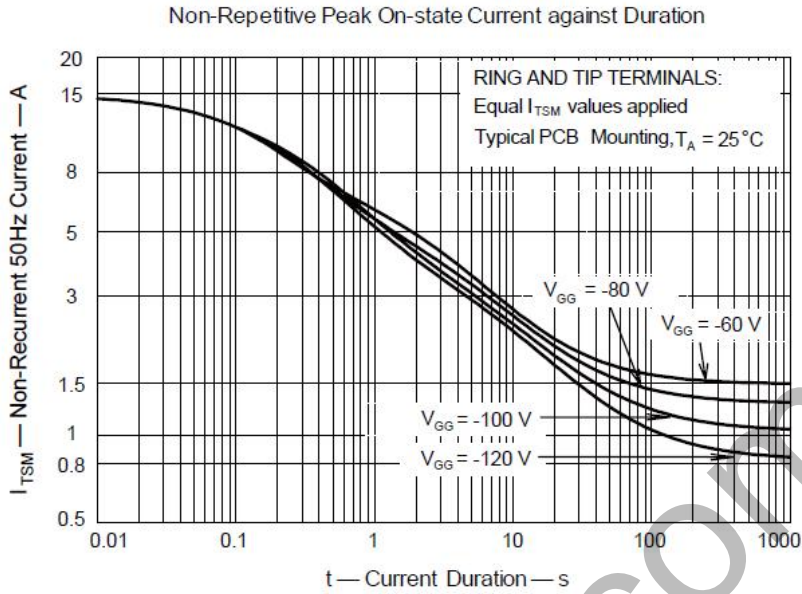
Absolute Maximum Ratings ($T_A=25^{\circ}\text{C}$)

Parameter	Symbol	Value	Unit
Non-repetitive peak on-state current 10/1000 μs 5/310 μs 2/10 μs	I_{PP}	30 40 120	A
Non-repetitive peak on-state current (sinusoidal) 60Hz 0.5s 1s 5s 30s 900s	I_{TSM}	6.5 4.5 2.4 1.3 0.72	A
Maximum voltage Line/Ground	V_{DRM}	-170	V
Maximum voltage Gate/Line	V_{GKRM}	-167	V
Operating free-air temperature range	T_A	-40 to +85	$^{\circ}\text{C}$
Storage temperature range	T_{STG}	-40 to +150	$^{\circ}\text{C}$
Junction temperature range	T_J	-40 to +150	$^{\circ}\text{C}$
Maximum lead temperature for soldering during 10s	T_L	260	$^{\circ}\text{C}$
Junction to free air thermal resistance	$R_{\theta JA}$	120	$^{\circ}\text{C/W}$

Parameter Measurement Information

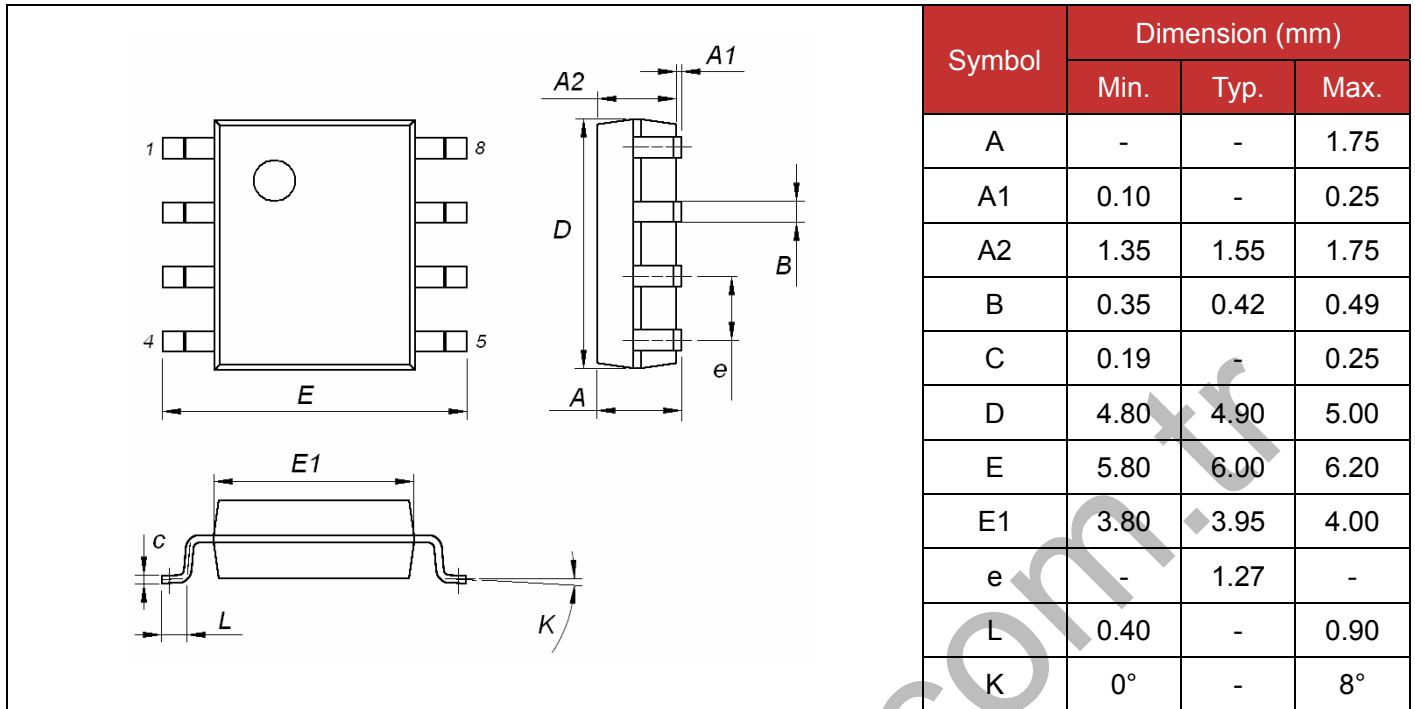
Parameter	Symbol
Off-state current	I_D
Holding current	I_H
Breakover voltage	$V_{(BO)}$
Forward voltage	V_F
Peak forward recovery voltage	V_{FRM}
Gate-cathode impulse breakover voltage	$V_{GK(BD)}$
Gate reverse current	I_{GKS}
Gate trigger current	I_{GT}
Gate-cathode trigger voltage	V_{GT}
Cathode-anode off-state capacitance	C_{KA}





Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V _F Forward voltage	I _F = 5A, t _w = 200μs			3	V
V _{FRM} Peak forward recovery voltage	2/10μs, I _F = 100A, R _S = 50Ω, di/dt = 80A/μs			10	V
I _D Off-state current	V _D = -170V, V _{GK} = 0 T _J = 25°C V _D = -170V, V _{GK} = 0 T _J = 85°C			-5 -50	μA
V _(BO) Breakover voltage	2/10μs, I _{TM} = 100A, R _S = 50Ω, di/dt = 80A/μs, V _{GG} = -100V			-112	V
I _H Holding current	I _T = -1A, di/dt = 1A/ms, V _{GG} = -100V	-150			mA
I _{GKS} Gate reverse current	V _{GG} = V _{GK} = -167V, V _{KA} = 0 T _J = 25°C V _{GG} = V _{GK} = -167V, V _{KA} = 0 T _J = 85°C			-5 -50	μA
I _{GT} Gate trigger current	I _T = -3A, t _{p(g)} ≥ 20μs, V _{GG} = -100V			5	mA
V _{GT} Gate-cathode trigger voltage	I _T = -3A, t _{p(g)} ≥ 20μs, V _{GG} = -100V		2.5	4	V
C _{KA} Cathode-anode off- state capacitance	f = 1MHz, V _d = 1V, I _G = 0 V _D = -3V f = 1MHz, V _d = 1V, I _G = 0 V _D = -48V			100 50	pF

Dimensions (SOP-8)



Tape Package Information

